

July 1988 Revised March 2001

## 100324

## Low Power Hex TTL-to-ECL Translator

#### **General Description**

The 100324 is a hex translator, designed to convert TTL logic levels to 100K ECL logic levels. The inputs are compatible with standard or Schottky TTL. A common Enable (E), when LOW, holds all inverting outputs HIGH and holds all true outputs LOW. The differential outputs allow each circuit to be used as an inverting/non-inverting translator, or as a differential line driver. The output levels are voltage compensated over the full -4.2V to -5.7V range.

When the circuit is used in the differential mode, the 100324, due to its high common mode rejection, overcomes voltage gradients between the TTL and ECL ground systems. The  $\rm V_{EE}$  and  $\rm V_{TTL}$  power may be applied in either order.

The 100324 is pin and function compatible with the 100124 with similar AC performance, but features power dissipation roughly half of the 100124 to ease system cooling requirements.

#### **Features**

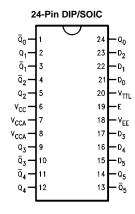
- Pin/function compatible with 100124
- Meets 100124 AC specifications
- 50% power reduction of the 100124
- Differential outputs
- 2000V ESD protection
- -4.2V to -5.7V operating range
- Available to MIL-STD-883
- Available to industrial grade temperature range (PLCC package only)

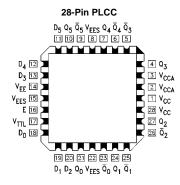
#### **Ordering Code:**

Order Number	Package Number	Package Description
100324SC	M24B	24-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-013, 0.300 Wide
100324PC	N24E	24-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-010, 0.400 Wide
100324QC	V28A	28-Lead Plastic Lead Chip Carrier (PLCC), JEDEC MO-047, 0.450 Square
100324QI	V28A	28-Lead Plastic Lead Chip Carrier (PLCC), JEDEC MO-047, 0.450 Square Industrial Temperature Range (–40°C to +85°C)

Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

#### **Connection Diagrams**





© 2001 Fairchild Semiconductor Corporation

DS009878

# **Pin Descriptions**

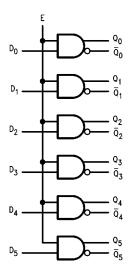
Pin Names	Description
D <sub>0</sub> –D <sub>5</sub>	Data Inputs
E	Enable Input
Q <sub>0</sub> -Q <sub>5</sub>	Data Outputs
$\overline{Q}_0 - \overline{Q}_5$	Complementary
	Data Outputs

# **Truth Table**

Inp	uts	Out	puts
D <sub>n</sub>	E	Q <sub>n</sub>	$\overline{Q}_n$
Х	L	L	Н
L	Н	L	Н
Н	H	Н	L

H = HIGH Voltage Level L = LOW Voltage Level

# Logic Diagram



#### **Absolute Maximum Ratings**(Note 1)

# Recommended Operating Conditions

Case Temperature (T<sub>C</sub>)

 $\begin{array}{ccc} \text{Commercial} & 0^{\circ}\text{C to } +85^{\circ}\text{C} \\ \text{Industrial} & -40^{\circ}\text{C to } +85^{\circ}\text{C} \\ \text{Supply Voltage (V}_{\text{EE}}) & -5.7\text{V to } -4.2\text{V} \end{array}$ 

Note 1: The "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. The device should not be operated at these limits. The parametric values defined in the Electrical Characteristics tables are not guaranteed at the absolute maximum rating. The "Recommended Operating Conditions" table will define the conditions for actual device operation.

Note 2: ESD testing conforms to MIL-STD-883, Method 3015.

#### **Commercial Version**

#### DC Electrical Characteristics (Note 3)

 $\rm V_{EE} = -4.2V~to~-5.7V,~V_{CC} = V_{CCA} = GND,~T_{C} = 0^{\circ}C~to~+85^{\circ}C,~V_{TTL} = +4.5V~to~+5.5V~to~+5.5V~to~+1$ 

Symbol	Parameter	Min	Тур	Max	Units	Conditions		
V <sub>OH</sub>	Output HIGH Voltage	-1025	-955	-870	mV	V <sub>IN</sub> =V <sub>IH</sub> (Max)	Loading with	
V <sub>OL</sub>	Output LOW Voltage	-1830	-1705	-1620	IIIV	or V <sub>IL (Min)</sub>	50Ω to −2.0V	
V <sub>OHC</sub>	Output HIGH Voltage	-1035			mV	$V_{IN} = V_{IH(Min)}$	Loading with	
V <sub>OLC</sub>	Output LOW Voltage			-1610	IIIV	or V <sub>IL (Max)</sub>	50Ω to −2.0V	
V <sub>IH</sub>	Input HIGH Voltage	2.0		5.0	V	Guaranteed HIGH	•	
						Signal for All Inputs		
V <sub>IL</sub>	Input LOW Voltage	0		0.8	V	Guaranteed LOW		
						Signal for All Inputs		
V <sub>CD</sub>	Input Clamp Diode Voltage	-1.2			V	$I_{IN} = -18 \text{ mA}$		
I <sub>IH</sub>	Input HIGH Current					$V_{IN} = +2.4V,$		
	Data			20	μΑ	All Other Inputs V <sub>IN</sub> =	GND	
	Enable			120				
	Input HIGH Current			1.0	mA	$V_{IN} = +5.5V,$		
	Breakdown Test, All Inputs			1.0	mA	All Other Inputs = GN	D	
I <sub>IL</sub>	Input LOW Current					$V_{IN} = +0.4V,$		
	Data	-0.9			mA	All Other Inputs V <sub>IN</sub> = V <sub>IH</sub>		
	Enable	-5.4						
I <sub>EE</sub>	V <sub>EE</sub> Power Supply Current	-70	-45	-22	mA	All Inputs V <sub>IN</sub> = +4.0V		
I <sub>TTL</sub>	V <sub>TTL</sub> Power Supply Current		25	38	mA	All Inputs V <sub>IN</sub> = GND		

Note 3: The specified limits represent the "worst case" value for the parameter. Since these values normally occur at the temperature extremes, additional noise immunity and guardbanding can be achieved by decreasing the allowable system operating ranges. Conditions for testing shown in the tables are chosen to guarantee operation under "worst case" conditions.

#### **DIP AC Electric Characteristics**

 $V_{EE} = -4.2 V$  to -5.7 V,  $V_{CC} = V_{CCA} = GND$ ,  $V_{TTL} = +4.5 V$  to +5.5 V

Symbol	Parameter	$T_C = 0^{\circ}C$		$T_C = +25$ °C		$T_C = +85^{\circ}C$		Units	Conditions
Cymbol		Min	Max	Min	Max	Min	Max	- Oille	Conditions
t <sub>PLH</sub>	Propagation Delay	0.50	3.00	0.50	2.90	0.50	3.00	ns	
t <sub>PHL</sub>	Data and Enable to Output	0.50	3.00	0.30	2.90	0.50	3.00	113	Figures 1, 2
t <sub>TLH</sub>	Transition Time	0.45	1.80	0.45	1.80	0.45	1.80	ns	
t <sub>THL</sub>	20% to 80%, 80% to 20%	0.40	1.00	0.43	1.00	0.43	1.00	113	

# 

Symbol	Parameter .	$T_C = 0^{\circ}C$		$T_C = +25^{\circ}C$		$T_C = +85^{\circ}C$		Units	Conditions
Cymbol		Min	Max	Min	Max	Min	Max	Onits	Conditions
t <sub>PLH</sub>	Propagation Delay	0.50	2.80	0.50	2.70	0.50	2.80	ns	
$t_{PHL}$	Data and Enable to Output	0.50	2.00	0.50	2.70	0.50	2.00	115	Figures 1, 2
t <sub>TLH</sub>	Transition Time	0.45	1.70	0.45	1.70	0.45	1.70	ns	
$t_{THL}$	20% to 80%, 80% to 20%	0.43	1.70	0.43	1.70	0.43	1.70	115	
toshl	Maximum Skew Common Edge								PLCC Only
	Output-to-Output Variation		0.95		0.95		0.95	ns	(Note 4)
	Data to Output Path								
toslh	Maximum Skew Common Edge								PLCC Only
	Output-to-Output Variation		0.70		0.70		0.70	ns	(Note 4)
	Data to Output Path								
tost	Maximum Skew Opposite Edge								PLCC Only
	Output-to-Output Variation		1.60		1.60		1.60	ns	(Note 4)
	Data to Output Path								
t <sub>PS</sub>	Maximum Skew								PLCC Only
	Pin (Signal) Transition Variation		1.20		1.20		1.20	ns	(Note 4)
	Data to Output Path								

Note 4: Output-to-Output Skew is defined as the absolute value of the difference between the actual propagation delay for any outputs within the same packaged device. The specifications apply to any outputs switching in the same direction either HIGH-to-LOW (t<sub>OSHL</sub>), or LOW-to-HIGH (t<sub>OSLH</sub>), or in opposite directions both HL and LH (t<sub>OST</sub>). Parameters t<sub>OST</sub> and t<sub>PS</sub> guaranteed by design.

#### **Industrial Version**

DC Electrical Characteristics (Note 5)  $\rm V_{EE} = -4.2V~to~-5.7V,~V_{CC} = V_{CCA} = GND,~T_C = -40^{\circ}C~to~+85^{\circ}C,~V_{TTL} = +4.5V~to~+5.5V$ 

Symbol	Parameter	T <sub>C</sub> =	–40°C	$T_C = 0^{\circ}C$	to +85°C	Units	Cox	Conditions		
Symbol		Min	Max	Min	Max	Units	Conditions			
V <sub>OH</sub>	Output HIGH Voltage	-1085	-870	-1025	-870	mV	V <sub>IN</sub> =V <sub>IH</sub> (Max)	Loading with		
V <sub>OL</sub>	Output LOW Voltage	-1830	-1575	-1830	-1620	IIIV	or V <sub>IL (Min)</sub>	$50\Omega$ to $-2.0V$		
√ <sub>онс</sub>	Output HIGH Voltage	-1095		-1035		mV	$V_{IN} = V_{IH(Min)}$	Loading with		
V <sub>OLC</sub>	Output LOW Voltage		-1565		-1610	IIIV	or V <sub>IL (Max)</sub>	$50\Omega$ to $-2.0\mbox{\ensuremath{\text{V}}}$		
V <sub>IH</sub>	Input HIGH Voltage	2.0	5.0	2.0	5.0	V	Guaranteed HIGI	+		
							Signal for All Inputs			
V <sub>IL</sub>	Input LOW Voltage	0	8.0	0	8.0	V Guaranteed LOW		I		
							Signal for All Inputs			
V <sub>CD</sub>	Input Clamp Diode Voltage	-1.2		-1.2		V	$I_{IN} = -18 \text{ mA}$			
IH	Input HIGH Current						$V_{IN} = +2.4V,$			
	Data		20		20	μΑ	All Other Inputs \	IN = GND		
	Enable		120		120					
	Input HIGH Current		1.0		1.0	mA	$V_{IN} = +5.5V,$			
	Breakdown Test, All Inputs		1.0		1.0	IIIA	All Other Inputs =	GND		
IL	Input LOW Current						$V_{IN} = +0.4V,$			
	Data	-0.9		-0.9		mA	All Other Inputs \	$V_{IN} = V_{IH}$		
	Enable	-5.4		-5.4						
EE	V <sub>EE</sub> Power Supply Current	-70	-22	-70	-22	mA	All Inputs V <sub>IN</sub> = +	4.0V		
TTL	V <sub>TTL</sub> Power Supply Current		38		38	mA	All Inputs V <sub>IN</sub> = G	IND		

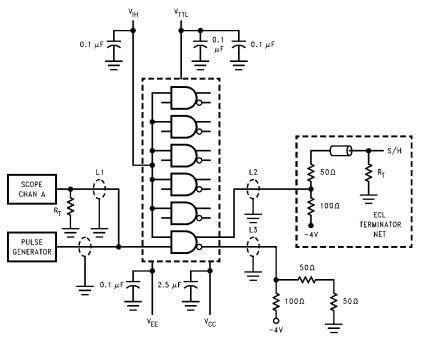
Note 5: The specified limits represent the "worst case" value for the parameter. Since these values normally occur at the temperature extremes, additional noise immunity and guardbanding can be achieved by decreasing the allowable system operating ranges. Conditions for testing shown in the tables are chosen to guarantee operation under "worst case" conditions.

#### **AC Electrical Characteristics**

 $\mbox{V}_{\mbox{\footnotesize EE}} = -4.2\mbox{V to} \; -5.7\mbox{V}, \; \mbox{V}_{\mbox{\footnotesize CC}} = \mbox{V}_{\mbox{\footnotesize CCA}} = \mbox{GND}, \; \mbox{V}_{\mbox{\footnotesize TTL}} = +4.5\mbox{V to} \; +5.5\mbox{V}$ 

Symbol	Parameter	$T_C = -40^{\circ}C$		T <sub>C</sub> = +25°C		T <sub>C</sub> = +85°C		Units	Conditions
		Min	Max	Min	Max	Min	Max	Oilles	Conditions
t <sub>PLH</sub> t <sub>PHL</sub>	Propagation Delay Data and Enable to Output	0.50	2.80	0.50	2.70	0.50	2.80	ns	Figures 1, 2
t <sub>TLH</sub> t <sub>THL</sub>	Transition Times 20% to 80%, 80% to 20%	0.35	1.80	0.45	1.70	0.45	1.70	ns	Figures 1, 2

# **Test Circuit**



#### Note:

- $\bullet \quad \text{$V_{CC}$, $V_{CCA} = 0V$, $V_{EE} = -4.5V$, $V_{TTL} = +5.0V$, $V_{IH} = +3.0V$}$
- L1, L2 and L3 = equal length  $50\Omega$  impedance lines
- $R_T = 50\Omega$  terminator internal to scope
- Decoupling 0.1  $\mu\text{F}$  from GND to  $V_{\text{CC}},\,V_{\text{EE}}$  and  $V_{\text{TTL}}$
- All unused outputs are loaded with  $50\Omega$  to  $-2\mbox{V}$  or with equivalent ECL terminator network
- $C_L$  = Fixture and stray capacitance  $\leq 3 \text{ pF}$

FIGURE 1. AC Test Circuit

# **Switching Waveform**

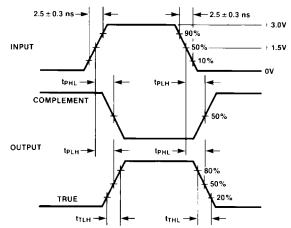
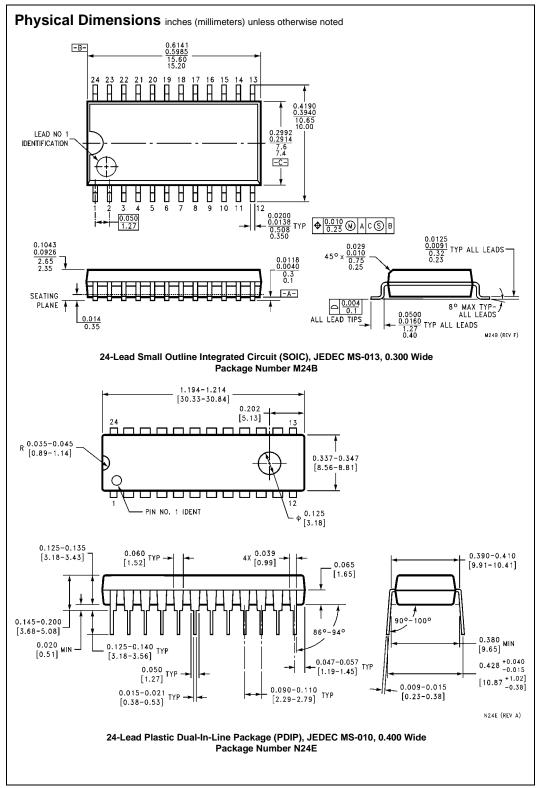
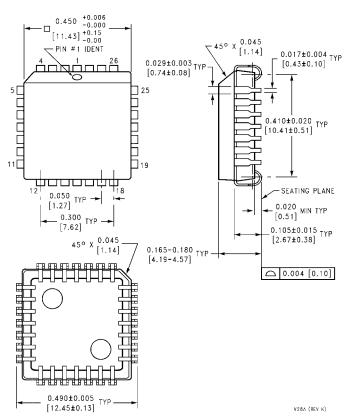


FIGURE 2. Propagation Delay and Transition Times



#### Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



28-Lead Plastic Lead Chip Carrier (PLCC), JEDEC MO-047, 0.450 Square Package Number V28A

Fairchild does not assume any responsibility for use of any circuitry described, no circuit patent licenses are implied and Fairchild reserves the right at any time without notice to change said circuitry and specifications.

#### LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF THE PRESIDENT OF FAIRCHILD SEMICONDUCTOR CORPORATION. As used herein:

- Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, and (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in a significant injury to the user.
- A critical component in any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

www.fairchildsemi.com

ON Semiconductor and in are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at <a href="www.onsemi.com/site/pdf/Patent-Marking.pdf">www.onsemi.com/site/pdf/Patent-Marking.pdf</a>. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by ON Semiconductor. "Typical" parameters which may be provided in ON Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights nor the rights of others. ON Semiconductor products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use ON Semiconductor products for any such unintended or unauthorized application, Buyer shall indemnify and hol

#### **PUBLICATION ORDERING INFORMATION**

#### LITERATURE FULFILLMENT:

Literature Distribution Center for ON Semiconductor 19521 E. 32nd Pkwy, Aurora, Colorado 80011 USA Phone: 303-675-2175 or 800-344-3860 Toll Free USA/Canada Fax: 303-675-2176 or 800-344-3867 Toll Free USA/Canada Email: orderlit@onsemi.com N. American Technical Support: 800–282–9855 Toll Free USA/Canada
Europe, Middle East and Africa Technical Support:
Phone: 421 33 790 2910

Phone: 421 33 790 2910

Japan Customer Focus Center

Phone: 81–3–5817–1050

ON Semiconductor Website: www.onsemi.com

Order Literature: http://www.onsemi.com/orderlit

For additional information, please contact your local Sales Representative

© Semiconductor Components Industries, LLC

www.onsemi.com